

What is claimed:

- 1           1.       A method for forming an air bearing surface on a slider, comprising,  
2           providing a silicon slider body;  
3           forming at least one trench in a surface of the silicon body; and  
4           forming a structure selected from the group consisting of a carbide structure and a  
5           nitride structure in the at least one trench.
- 1           2.       A method as in claim 1, wherein the structure comprises a carbide structure.
- 1           3.       A method as in claim 1, further comprising forming at least one of a read  
2           element and a write element on the surface after forming the structure.
- 1           4.       A method as in claim 1, further comprising forming a carbon layer over at  
2           least a portion of the silicon body on the surface of the slider.
- 1           5.       A method as in claim 1, further comprising forming the trench by etching a  
2           portion of the silicon body.
- 1           6.       A method as in claim 2, further comprising forming a layer between the  
2           silicon body and the carbide structure.
- 1           7.       A method as in claim 6, wherein the layer comprises a material comprising  
2           titanium.
- 1           8.       A method as in claim 6, wherein the layer comprises a material that improves  
2           adhesion between the carbide and the silicon.

1           9.     A method as in claim 2, wherein the carbide structure is formed by a process  
2 comprising:

3                 filling the trench in the silicon body with a metal carbide and anhydrous metal  
4 chloride material;

5                 heating the silicon body so that the metal carbide and anhydrous metal chloride  
6 material becomes a melt;

7                 after the heating the silicon body, cooling the silicon body to produce a product  
8 material from metal carbide and anhydrous metal chloride material; and

9                 removing chloride material formed from the product material.

1           10.    A method as in claim 9, further comprising, after the heating the silicon body  
2 so that the metal carbide and anhydrous metal chloride material becomes a melt, annealing  
3 the silicon body for a predetermined time period.

1           11.    A method as in claim 9, wherein removing chloride material comprises  
2 rinsing the surface of the material with at least one liquid selected from the group consisting  
3 of water and methanol to remove the chloride material.

1           12.    A method as in claim 9, further comprising planarizing the carbide using a  
2 method selected from the group consisting of etching and polishing.

1           13.    A method as in claim 12, further comprising etching the silicon slider body  
2 so that the carbide extends outward from the etched silicon slider body.

1           14.    A method as in claim 9, wherein the heating the silicon body comprises  
2 heating the metal carbide and anhydrous metal chloride material to a temperature of at least  
3 450°C.

1           15.     A method as in claim 1, wherein the structure comprises a nitride structure.

1           16.     A method for forming a slider comprising:

2           forming at least one trench into a silicon body;

3           forming an air bearing surface pad structure in the trench that extends to a position at  
4     or above the silicon body; and

5           forming a read/write head on the silicon body after forming the air bearing surface  
6     pad structure.

1           17.     A method as in claim 16, wherein the air bearing surface pad structure  
2     comprises a material selected from the group consisting of a carbide material and a nitride  
3     material.

1           18.     A method as in claim 16, further comprising:

2           forming at least one groove in the silicon body extending from a first position at or  
3     adjacent to the read/write head to second position at or adjacent to an edge of the slider;

4           forming an insulating layer in the groove; and

5           forming a conducting layer on the insulating layer in the groove to provide an  
6     electrical path between the read/write head and the edge of the slider.

1           19.     A method as in claim 16, wherein the silicon slider body is formed from a  
2     material consisting of single crystal silicon.

1           20.     A method as in claim 16, wherein the read/write structure is formed to  
2     include an atomic force microscopy tip.

1        21.     A method for processing a slider, comprising:  
2        forming at least one trench in a silicon slider body;  
3        depositing precursor materials in the at least one trench;  
4        heating the precursor materials to form a product including a metal carbide and a  
5        metal chloride; and  
6        removing the metal chloride.

1        22.     A method as in claim 21, further comprising forming a layer in the at least  
2        one trench prior to the depositing precursor materials in the trench.

1        23.     A method as in claim 21, further comprising depositing the precursor  
2        materials on a surface of the silicon slider body adjacent to the at least one trench and  
3        planarizing the metal carbide so that the metal carbide in the at least one trench is planarized  
4        to a level identical to that of the surface of the silicon slider body adjacent to the at least one  
5        trench.

1        24.     A method as in claim 23, further comprising, after the planarizing the metal  
2        carbide, etching the surface of the silicon slider body adjacent to the at least one trench so  
3        that the metal carbide in the at least one trench extends outward relative to the etched  
4        surface of the silicon slider body adjacent to the at least one trench.

1        25.     A method as in claim 21, wherein the precursor materials are selected so that  
2        the metal carbide comprises a carbide selected from the group consisting of titanium  
3        carbide, zirconium carbide, vanadium carbide, tungsten carbide, and molybdenum carbide.

1        26.     A method as in claim 21, wherein the silicon slider body is formed from a  
2        material consisting of single crystal silicon.

1           27.     A method as in claim 24, further comprising forming a carbon layer on at  
2     least part of the etched surface of the silicon slider body.

1           28.     A method as in claim 24, further comprising forming a read/write structure  
2     after the etching the surface of the silicon slider body adjacent to the at least one trench.

1           29.     A method as in claim 28, wherein the read/write structure is formed to  
2     include an atomic force microscopy tip.